# onsemi

## <u>Silicon Carbide (SiC)</u> <u>MOSFET</u> – 60 mohm, 900 V, M2, TO-247-3L

### NTHL060N090SC1

#### Features

- Typ.  $R_{DS(on)} = 60 \text{ m}\Omega @ V_{GS} = 15 \text{ V}$
- Typ.  $R_{DS(on)} = 43 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge (typ.  $Q_{G(tot)} = 87 \text{ nC}$ )
- Low Effective Output Capacitance (typ. Coss = 113 pF)
- 100% UIL Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### Typical Applications

- UPS
- DC–DC Converter
- Boost Inverter

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	900	V	
Gate-to-Source Voltage			V <sub>GS</sub>	+22/-8	V
Recommended Opera- tion Values of Gate-to- Source Voltage	T <sub>C</sub> < 175°C		V <sub>GSop</sub>	+15/-5	V
Continuous Drain Current $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	46	А
Power Dissipation $R_{\theta JC}$	State	•	PD	221	W
Continuous Drain Current $R_{\theta JC}$	Steady $T_{\rm C} = 100^{\circ}{\rm C}$	Ι <sub>D</sub>	32	А	
Power Dissipation $R_{\theta JC}$	State	0	PD	110	W
Pulsed Drain Current (Note 2)	T <sub>A</sub> = 25°C		I <sub>DM</sub>	184	A
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C	
Source Current (Body Diode)		I <sub>S</sub>	22	А	
Single Pulse Drain-to-Source Avalanche Energy ( $I_{L(pk)} = 18 \text{ A}, L = 1 \text{ mH}$ ) (Note 3)		E <sub>AS</sub>	162	mJ	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Note 1)	$R_{\theta JC}$	0.68	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	40	°C/W

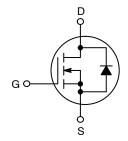
1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Repetitive rating, limited by max junction temperature.

3. E<sub>AS</sub> of 162 mJ is based on starting T<sub>J</sub> = 25°C; L = 1 mH, I<sub>AS</sub> = 18 A, V<sub>DD</sub> = 100 V, V<sub>GS</sub> = 15 V.

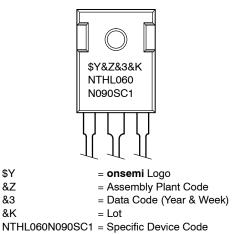
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
900 V	84 mΩ @ 15 V	46 A

#### **N-CHANNEL MOSFET**





#### MARKING DIAGRAM



#### ORDERING INFORMATION

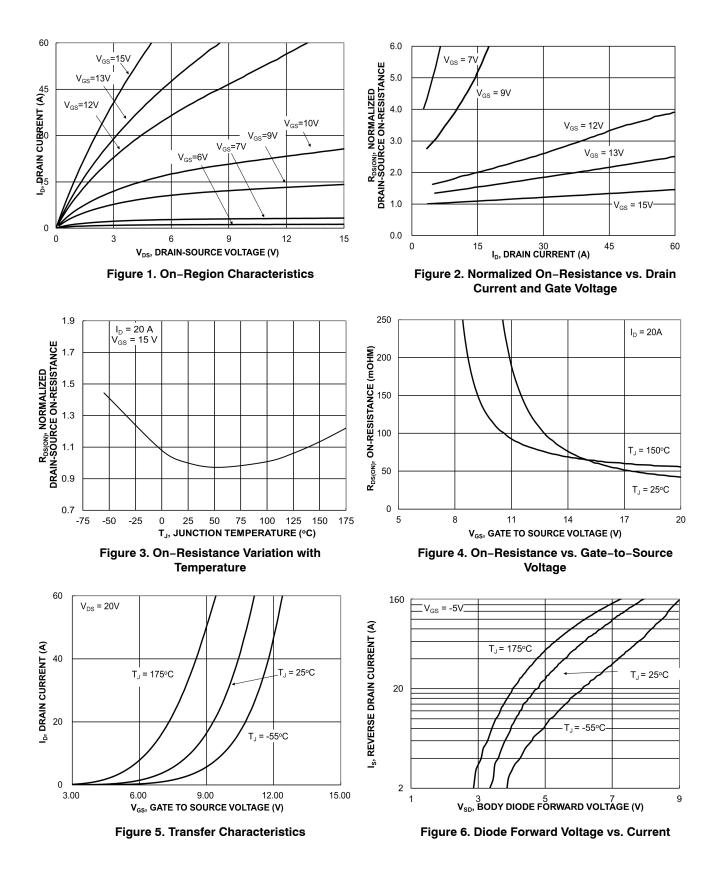
Device	Package	Shipping		
NTHL060N090SC1	TO247-3L	30 Units / Tube		

#### **ELECTRICAL CHARACTERISTICS**

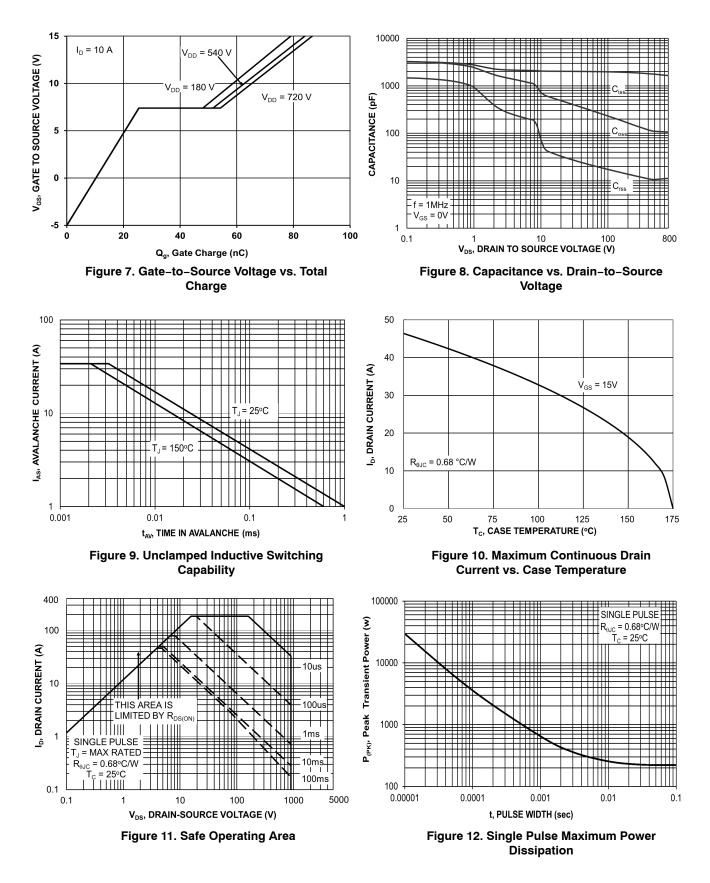
Parameter	Symbol	Test Conditions	Min	Тур	Мах	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 1 mA$	900			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = 1$ mA, referenced to $25^{\circ}C$		574		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS}$ = 0 V, $V_{DS}$ = 900 V, $T_{J}$ = 25°C			100	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}, T_{J} = 175^{\circ}\text{C}$			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +22/-8 V, V_{DS} = 0 V$			±1	μΑ
ON CHARACTERISTICS		· · · · ·			1	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}$ , $I_D = 5 \text{ mA}$	1.8	2.7	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>		-5		+15	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 15 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 25°C		60	84	mΩ
		$V_{GS}$ = 18 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 25°C		43		
		$V_{GS}$ = 15 V, $I_D$ = 20 A, $T_J$ = 175°C		76	135	
Forward Transconductance	9fs	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 20 A		17		S
CHARGES, CAPACITANCES & GATE	RESISTANCE	· · · · · ·				
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 450 V		1770		pF -
Output Capacitance	C <sub>OSS</sub>			113		
Reverse Transfer Capacitance	C <sub>RSS</sub>			11		
Total Gate Charge	Q <sub>G(tot)</sub>	$V_{GS} = -5/15$ V, $V_{DS} = 720$ V, $I_D = 10$ A		87		nC
Threshold Gate Charge	Q <sub>G(th)</sub>			17		
Gate-to-Source Charge	Q <sub>GS</sub>			27		
Gate-to-Drain Charge	Q <sub>GD</sub>			26		
Gate Resistance	R <sub>G</sub>	f = 1 MHz		3.0		Ω
SWITCHING CHARACTERISTICS	•	· · · ·			1	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = -5/15 \text{ V}, \text{ V}_{DS} = 720 \text{ V},$		22	40	ns μJ
Rise Time	t <sub>r</sub>	$I_D = 20 \text{ A}, \text{ R}_G = 2.5 \Omega,$ Inductive Load		33	66	
Turn-Off Delay Time	t <sub>d(off)</sub>			31	74	
Fall Time	t <sub>f</sub>			11	20	
Turn-On Switching Loss	E <sub>ON</sub>			464		
Turn-Off Switching Loss	E <sub>OFF</sub>			23		
Total Switching Loss	E <sub>TOT</sub>	1		487		
DRAIN-SOURCE DIODE CHARACTER	RISTICS	· · · ·			1	1
Continuous Drain-to-Source Diode Forward Current	I <sub>SD</sub>	$V_{GS}$ = -5 V, T <sub>J</sub> = 25°C			22	A
Pulsed Drain-to-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>	$V_{GS}$ = -5 V, $T_J$ = 25°C			184	A
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS}$ = -5 V, $I_{SD}$ = 10 A, $T_{J}$ = 25°C		3.9		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5/15 \text{ V}, I_{SD} = 30 \text{ A},$ dI <sub>S</sub> /dt = 1000 A/µs, V <sub>DS</sub> = 720 V		18		ns
Reverse Recovery Charge	Q <sub>RR</sub>			84		nC
Reverse Recovery Energy	E <sub>REC</sub>			1.0		μJ
Peak Reverse Recovery Current	I <sub>RRM</sub>			9.0		A
Charge Time	t <sub>a</sub>			10		ns
Discharge Time	t <sub>b</sub>			8.0	1	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

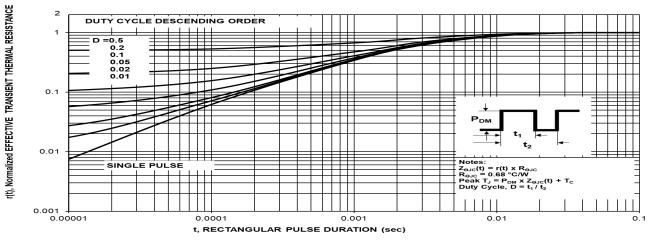


Figure 13. Junction-to-Ambient Thermal Response



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